A Complete Bibliography of Publications in *Technometrics* for the decade 2020–2029

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13 October 2023
Version 1.08

Title word cross-reference

$102.12 [Els20]. **$107.78** [Wlu21]. **$118.00** [Mal23a]. **$119.35** [Mye21]. **$119.99** [Lip20d]. **$120.00** [Lip23f]. **$123.83** [Ahm21d]. **$129.00** [Lip20h, Lip21l]. **$130.00** [Lip21m, Lip22j, Mal23c]. **$135** [Nel21]. **$135.00** [Lip21b]. **$136.46** [Sau23]. **$136.93** [Ahm21c]. **$140.00** [Che22, Lip21h, Ndo24]. **$152.00** [Lip21g]. **$160.00** [Lip20a, Lip21c]. **$174.95** [VL21b]. **$179.99** [Ahm20a]. **$185.15** [Zel22]. **$19.99** [ZGAR24]. **$200.00** [Lip23c]. **$23.96** [Lip23d]. **$23.99** [Kha23]. **$24.95** [Fir23]. **$25.00** [Mal22a]. **$28.00** [Lip22b]. 2^5 [Lip21a]. 3 [OKF22, SA23b]. **$31.16** [Lip23g]. **$34.00** [Lip23a]. **$37.99** [Lip20c]. **$38.00** [Lip22a]. **$39.99** [Lip23b]. **$46.36** [Lip21g, Lip21h, Wlu21]. **$49.99** [Lip22h]. **$50** [Ano21d]. **$50.78** [Mal20]. **$52.49** [Mal23b]. **$53.59** [MD24]. **$54.95** [Lip22n]. **$55.96** [Lip22i]. **$59.96** [Lip21e, Lip21d]. **$59.98** [Ahm20d]. **$63.96** [Lip22c, Lip22g]. **$64.99** [Mal23d]. **$66.95** [Lip22m]. **$68** [Mal23e]. **$69.99** [Lip20f, Lip24a]. **$74.99** [Ano21b, Lip20e]. **$75.95** [Lip21f]. **$76.64** [DM20]. **$79.95**

Lip21g, Lip21f, Lip21e, Lip21d, Lip21j, Lip21l, Lip21m, Lip22d, Lip22a, Lip22b, Lip22e, Lip22l, Lip22f, Lip22i, Lip22k, Lip22j, Lip23a, Lip23b, Lip23f, Lip23c, Lip23d, Lip23g, Lip24a, Lip24b, Liu21, Lu20, Mal22a, Mal22b, Mal22c, Mal23a, Mal23b, Mal23c, Mal23d, Mal23e, MD24, Mal20, Mal21, Ndo24, Nel21, Oli20, Oli22, Rah23, Sa'23a, Sea20, VL21b, Wlu21, Wlu23, Zel22, ZGAR24].
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